

Search Notes

Application/Control No.

10/801,009

Examiner

Erin D. Chiem

Applicant(s)/Patent under
Reexamination

KANEKO ET AL.

Art Unit

2883

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search	1/17/2006	EDC
(385/59-70 and adapter near connector) and (short stub long near2 fib\$2 and short and (bent bend\$4)	1/17/2006	EDC
adapter with v adj groove	1/18/2006	EDC